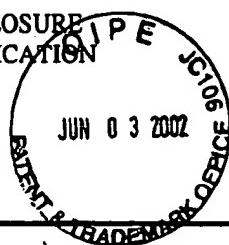


FORM PTO-1449

INFORMATION DISCLOSURE
CITATION IN AN APPLICATIONDOCKET NUMBER
SLA1038APPLICATION NUMBER
09/683,667APPLICANT
Andrew Rodney FerlitschFILING DATE:
January 31, 2002GROUP ART UNIT
2176

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